## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination SAITO ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0137595	07-2003	TAKACHI, TAIZO	348/340
*	В	US-2003/0223008	12-2003	Kim et al.	348/340
*	С	US-5,233,379	08-1993	Burnham, William L.	396/349
*	D	US-6,738,570	05-2004	Shinohara et al.	396/25
*	E	US-2002/0167605	11-2002	Akimoto et al.	348/374
*	F	US-2002/0191103	12-2002	Akimoto et al.	348/374
*	G	US-5,324,888	06-1994	Tyler et al.	174/536
*	Н	US-6,940,058	09-2005	Shiau, Simon	250/208.1
*	l,	US-6,483,101	11-2002	Webster, Steven	250/216
*	J	US-4,897,508	01-1990	Mahulikar et al.	174/522
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Ρ	·				
	Q					
	R					
	s					
	т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	<b>v</b>	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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